Search	n Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/774,596	YOKOYAMA ET AL	
Examiner	Art Unit	
Loopid Shanira	2620	

SEARCHED				
Class	Subclass	Date	Examiner	
345	178	49	02.20,00	
	156			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
THE	SAME	07.03.07	28	
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SEARCH NOT (INCLUDING SEARCH		)
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Inventor	02.20.07	<b>L</b> s